## NSN 6625-01-460-7146

Fiig: T228-a

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View Online at https://aerobasegroup.com/nsn/6625-01-460-7146 Width: 11.450 inches Ac Voltage Rating: 100.0 volts and 230.0 volts Frequency Rating: 60.0 hertz **Major Components:** Tr210; instruction manual; one set atl25 test probes; common test leads; two mini-clip leads; u.S. Power cord Depth: 10.200 inches **End Application:** Used with tds210 or tds 220 digital real time oscilloscopes **Electrical Power Source Relationship:** Operating **Inclosure Feature:** Single item w/housing **Test Type For Which Designed:** Current voltage analog signature **Operating Test Capability:** Test frequency 50 hz or 60 hz, 200 hz, 2,000 hz; pulse generator 0 v to5 v Phase: Two **Special Features:** Built-in pulse generator **Functional Description:** Provides advanced troubleshooting capabilities to simplify testing of cmos and mos circuits; troubleshoots gate-fired scrs, triacs, and opto-couplers Height: 2.450 inches Shelf Life: N/a **Unit Of Measure: Demilitarization:** No